20 V, 7.0 A, Low $V_{CE(sat)}$ NPN Transistor

NSS20501UW3

onsemi's e^2PowerEdge family of low $V_{CE(sat)}$ transistors are miniature surface mount devices featuring ultra low saturation voltage ($V_{CE(sat)}$) and high current gain capability. These are designed for use in low voltage, high speed switching applications where affordable efficient energy control is important.

Typical applications are DC−DC converters and power management in portable and battery powered products such as cellular and cordless phones, PDAs, computers, printers, digital cameras and MP3 players. Other applications are low voltage motor controls in mass storage products such as disc drives and tape drives. In the automotive industry they can be used in air bag deployment and in the instrument cluster. The high current gain allows e^2PowerEdge devices to be driven directly from PMU's control outputs, and the Linear Gain (Beta) makes them ideal components in analog amplifiers.

Features

- This is a Pb−Free Device

MAXIMUM RATINGS (T_A = 25°C)

Rating	Symbol	Max	Unit
Collector-Emitter Voltage	V_{CEO}	20	Vdc
Collector-Base Voltage	V_{CBO}	20	Vdc
Emitter-Base Voltage	V_{EBO}	6.0	Vdc
Collector Current − Continuous	I_C	5.0	Adc
Collector Current − Peak	I_{CM}	7.0	A
Electrostatic Discharge	ESD	HBM Class 3B MM Class C	

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Total Device Dissipation, T_A = 25°C Derate above 25°C	P_D (Note 1)	875 7.0	mW mW/°C
Thermal Resistance, Junction−to−Ambient	$R_{\theta JA}$ (Note 1)	143	°C/W
Total Device Dissipation, T_A = 25°C Derate above 25°C	P_D (Note 2)	1.5 11.8	W mW/°C
Thermal Resistance, Junction−to−Ambient	$R_{\theta JA}$ (Note 2)	85	°C/W
Thermal Resistance, Junction−to−Lead #3	$R_{\theta JL}$ (Note 2)	23	°C/W
Junction and Storage Temperature Range	T_J, T_{stg}	−55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
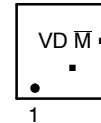1. FR−4 @ 100 mm², 1 oz copper traces.
2. FR−4 @ 500 mm², 1 oz copper traces.

20 VOLTS, 7.0 AMPS NPN LOW $V_{CE(sat)}$ TRANSISTOR EQUIVALENT $R_{DS(on)}$ 31 mΩ

COLLECTOR 3

1 BASE

2 EMITTER
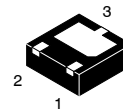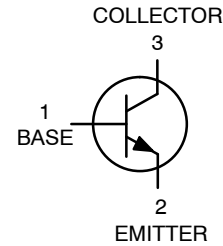
WDFN3 CASE 506AU

MARKING DIAGRAM

VD $\overline{M}$ ▪

1

VD = Specific Device Code
$\overline{M}$ = Date Code
▪ = Pb−Free Package
(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping[†]
NSS20501UW3T2G	WDFN3 (Pb−Free)	3000/ Tape & Reel
NSS20501UW3TBG	WDFN3 (Pb−Free)	3000/ Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

April, 2024 − Rev. 4

Publication Order Number:
NSS20501UW3/D

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS					
Collector – Emitter Breakdown Voltage (I_C = 10 mAdc, I_B = 0)	$V_{(BR)CEO}$	20	–	–	Vdc
Collector – Base Breakdown Voltage (I_C = 0.1 mAdc, I_E = 0)	$V_{(BR)CBO}$	20	–	–	Vdc
Emitter – Base Breakdown Voltage (I_E = 0.1 mAdc, I_C = 0)	$V_{(BR)EBO}$	6.0	–	–	Vdc
Collector Cutoff Current (V_{CB} = 20 Vdc, I_E = 0)	I_{CBO}	–	–	0.1	μAdc
Emitter Cutoff Current (V_{EB} = 6.0 Vdc)	I_{EBO}	–	–	0.1	μAdc
ON CHARACTERISTICS					
DC Current Gain (Note 3) (I_C = 10 mA, V_{CE} = 2.0 V) (I_C = 500 mA, V_{CE} = 2.0 V) (I_C = 1.0 A, V_{CE} = 2.0 V) (I_C = 2.0 A, V_{CE} = 2.0 V) (I_C = 3.0 A, V_{CE} = 2.0 V)	h_{FE}	200 200 200 200 180	– – 325 310 300	– – – – –	
Collector – Emitter Saturation Voltage (Note 3) (I_C = 0.1 A, I_B = 0.010 A) (I_C = 1.0 A, I_B = 0.100 A) (I_C = 1.0 A, I_B = 0.010 A) (I_C = 2.0 A, I_B = 0.020 A) (I_C = 3.0 A, I_B = 0.030 A) (I_C = 4.0 A, I_B = 0.400 A)	$V_{CE(sat)}$	– – – – – –	0.007 0.031 0.045 0.070 0.120 0.110	0.008 0.040 0.075 0.100 0.135 0.125	V
Base – Emitter Saturation Voltage (Note 3) (I_C = 1.0 A, I_B = 0.01 A)	$V_{BE(sat)}$	–	0.760	0.900	V
Base – Emitter Turn–on Voltage (Note 3) (I_C = 2.0 A, V_{CE} = 2.0 V)	$V_{BE(on)}$	–	0.730	0.900	V
Cutoff Frequency (I_C = 100 mA, V_{CE} = 5.0 V, f = 100 MHz)	f_T	150	–	–	MHz
Input Capacitance (V_{EB} = 0.5 V, f = 1.0 MHz)	Cibo	–		650	pF
Output Capacitance (V_{CB} = 3.0 V, f = 1.0 MHz)	Cobo	–		70	pF
SWITCHING CHARACTERISTICS					
Delay (V_{CC} = 15 V, I_C = 750 mA, I_{B1} = 15 mA)	t_d	–	–	90	ns
Rise (V_{CC} = 15 V, I_C = 750 mA, I_{B1} = 15 mA)	t_r	–	–	100	ns
Storage (V_{CC} = 15 V, I_C = 750 mA, I_{B1} = 15 mA)	t_s	–	–	500	ns
Fall (V_{CC} = 15 V, I_C = 750 mA, I_{B1} = 15 mA)	t_f	–	–	100	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulsed Condition: Pulse Width = 300 μsec, Duty Cycle ≤ 2%.
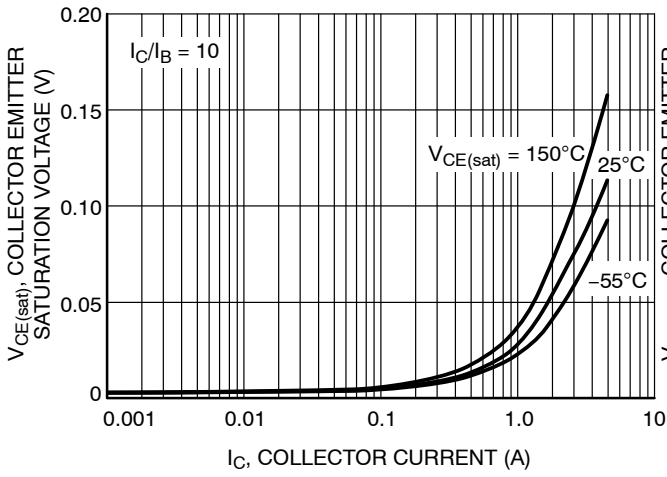
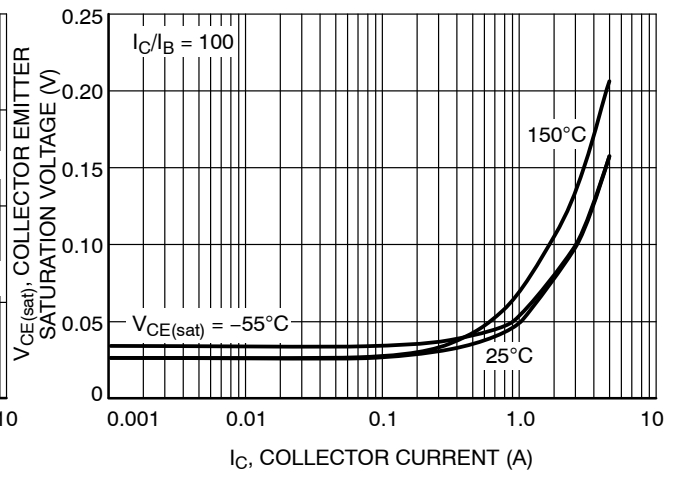**Figure 1. Collector Emitter Saturation Voltage vs. Collector Current**

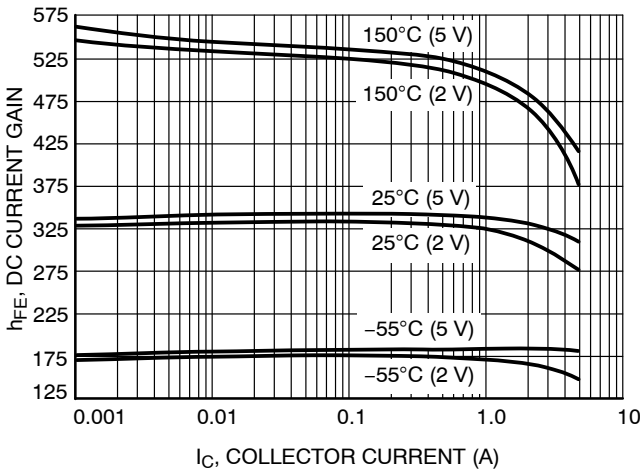**Figure 2. Collector Emitter Saturation Voltage vs. Collector Current**

Figure 3. DC Current Gain vs. Collector Current
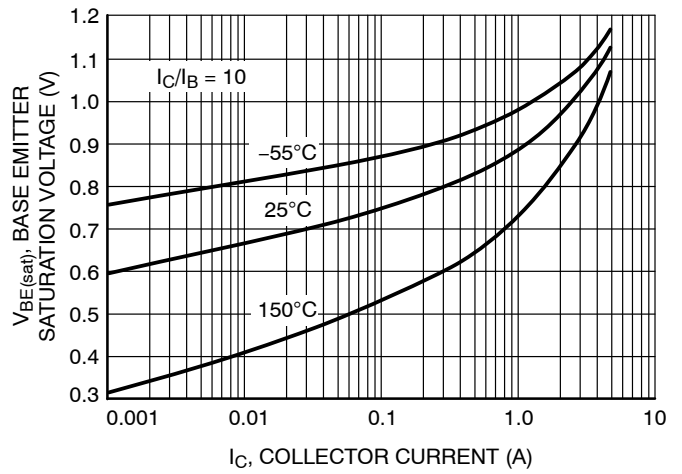

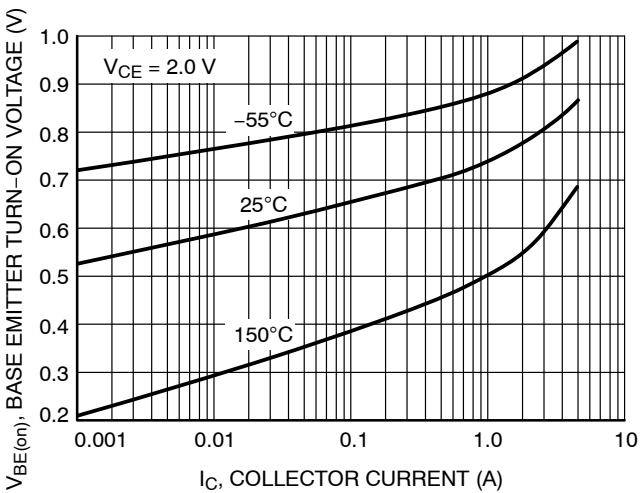**Figure 4. Base Emitter Saturation Voltage vs. Collector Current**

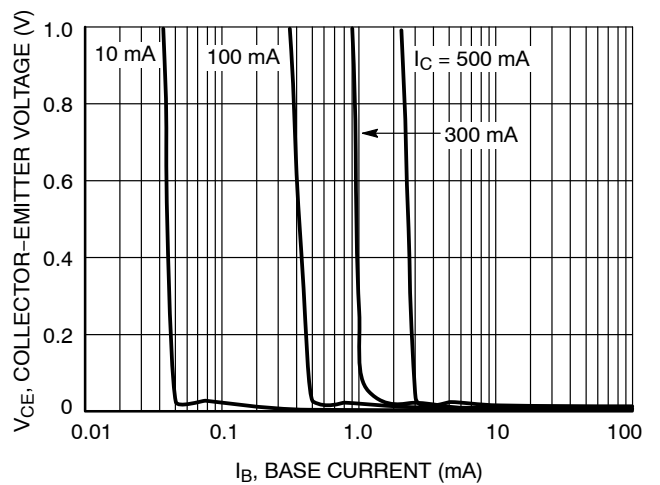**Figure 5. Base Emitter Turn−On Voltage vs. Collector Current**

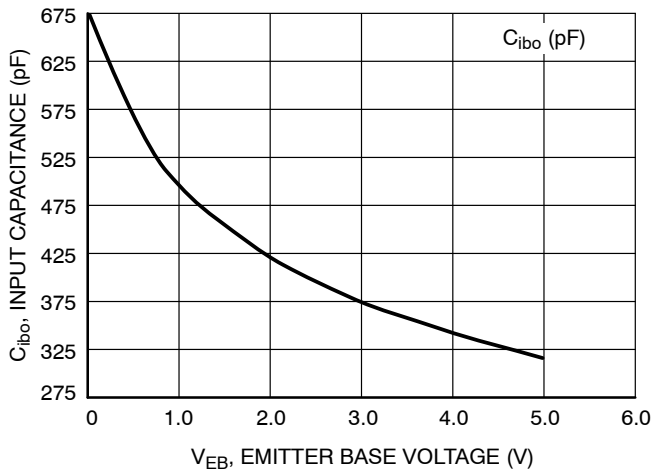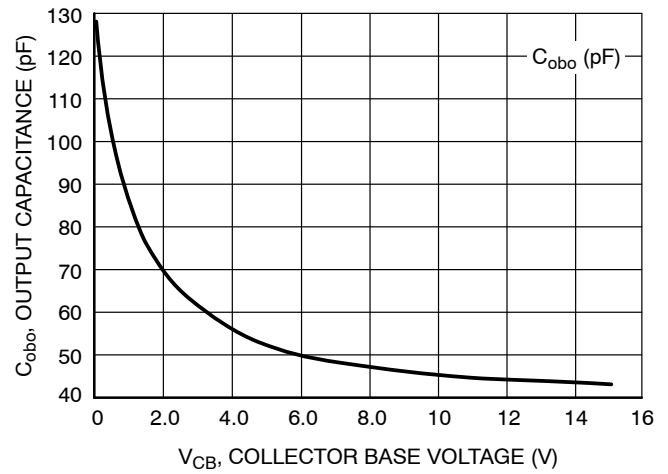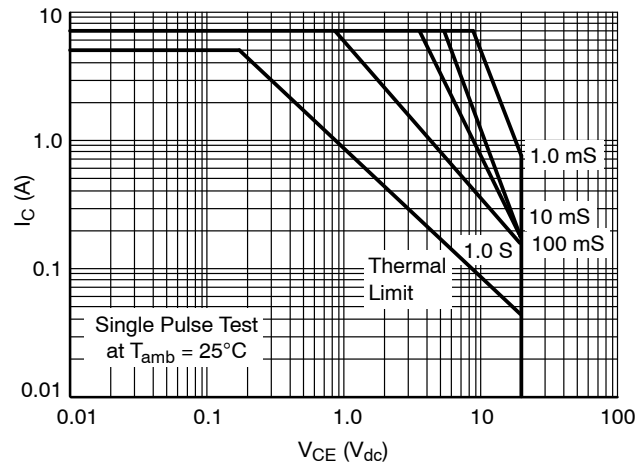**Figure 6. Saturation Region**

Figure 7. Input Capacitance

Figure 8. Output Capacitance

Figure 9. Safe Operating Area

WDFN3 2x2, 1.3P
CASE 506AU
ISSUE A

DATE 18 AUG 2016

SCALE 4:1

1

PIN ONE REFERENCE

2 X
◹ 0.10 C

2 X
◹ 0.10 C

TOP VIEW

⟋ 0.10 C

8 X
◹ 0.08 C

SEATING PLANE

SIDE VIEW

A1

(A3)

C

D2
e
e/2

2X L

1
2

K

E2

3
3X b ⊕ | 0.10 | C | A | B
| 0.05 | C | NOTE 3

BOTTOM VIEW

NOTES:
1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994 .
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

DIM	MILLIMETERS			INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
A3	0.20 REF			0.008 REF		
b	0.25	0.30	0.35	0.010	0.012	0.014
D	2.00 BSC			0.079 BSC		
D2	1.40	1.50	1.60	0.055	0.059	0.063
E	2.00 BSC			0.079 BSC		
E2	0.90	1.00	1.10	0.035	0.039	0.043
e	1.30 BSC			0.051 BSC		
K	0.35 REF			0.014 REF		
L	0.35	0.40	0.45	0.014	0.016	0.018

GENERIC MARKING DIAGRAM*

XX M
1

XX = Specific Device Code
M = Date Code

*This information is generic. Please refer to device data sheet for actual part marking.
Pb–Free indicator, "G" or microdot " ▪ ", may or may not be present.

SOLDERING FOOTPRINT*

1.300
2X 0.400
0.600
0.250
0.300
1.100
0.400
0.275
1.600
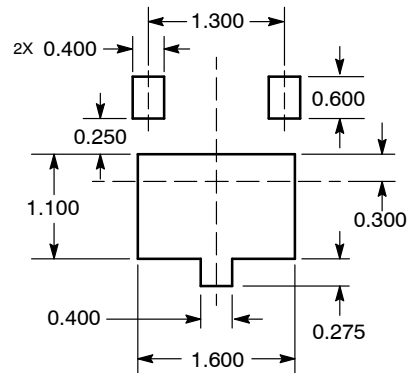
DIMENSIONS: MILLIMETERS

*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	**WDFN3 2X2, 1.3P**		**PAGE 1 OF 1**

ADDITIONAL INFORMATION

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